Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/714,557	STAHL ET AL.	
Examiner	Art Unit	
Joon H. Hwang	2166	

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
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SEARCH N (INCLUDING SEARC		<b>(</b> )
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Palm Inventor searched see search history printout(s)	2/1/2007	JH
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